

Search Notes

Application/Control No.

10/519,461

Examiner

James D. Stein

Applicant(s)/Patent under
Reexamination

JIN ET AL.

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
385	28,50	2/10/2006	JDS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attached EAST search history	2/10/2006	JDS
IEEE and INSPEC search	2/10/2006	JDS